



TECHNICAL MEMORANDUM:
**PROJECTING LONG-TERM LUMEN,
PHOTON, AND RADIANT FLUX
MAINTENANCE OF LED LIGHT SOURCES**
AN AMERICAN NATIONAL STANDARD



ANSI/IES TM-21-19

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Publication of this Committee report
has been approved by IES.
Suggestions for revision
should be directed to IES.



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1.0 Introduction and Scope

1.1 Introduction

One of the benefits that LED light sources can provide is very long usable life. Unlike other lighting technologies, LEDs typically do not fail catastrophically* during use. However, over time the light output will gradually depreciate. At some point in time the light emitted from an LED depreciates to a level where it is no longer considered adequate for a specific application. It is important in lighting design to understand when this “useful lifetime” of an LED source is reached.

ANSI/IES LM-80-15, Approved Method for Measuring Luminous Flux and Color Maintenance of LED Packages, Arrays and Modules, defines the setup, conditions, and procedures for performing lumen maintenance testing of LED light sources. ANSI/IES LM-80-15 is the IES standard that is used widely to measure the lumen depreciation behavior of LEDs. LED device manufacturers routinely provide ANSI/IES LM-80-15 reports for their products, with data collected during testing for 6,000 hours or more. However, how the data collected from ANSI/IES LM-80-15 testing is used to best determine the useful lifetime of the tested product is not well defined.

The rated flux maintenance life of an LED is the elapsed operating time over which an LED light source maintains a given percentage of its initial light output. It is defined as τ_p , where τ is the lumen, photon or radiant flux, and p is the percentage value. For example, L_{70} is the time (in hours) when the luminous flux output from the LED has dropped to 70% of initial; Q_{90} is the time (in hours) when the photon flux output from the LED has dropped to 90% of initial; R_{80} is the time (in hours) when the radiant flux output from the LED has dropped to 80% of initial. The flux maintenance of an LED light source is dependent upon many variables, including the operating temperature, drive current, and technology and materials used to construct the product. As such, the flux maintenance of LEDs can vary not only from manufacturer to manufacturer, but also

* Used in this sense, a “catastrophic failure” is a sudden failure that results in a complete inability to perform all required functions of an item.” (Laplante, Philip A. Dictionary of Computer Science, Engineering and Technology. CRC Press, 2017)

between different LED package types produced by a single manufacturer.

This Technical Memorandum recommends a method of projecting the flux maintenance of LED light sources from the data obtained by ANSI/IES LM-80-15 testing. This document was developed by a dedicated TM-21 Working Group of LED industry professionals. The analyses of the ANSI/IES LM-80-15 test data provided by major LED manufacturers are used to rationalize and support this document. Much of the ANSI/IES LM-80-15 data came from testing that extended to 9,000 hours, and in some cases beyond.

Note: In 2018, IES issued *PS-10-18, IES Position on LED Product Lifetime Prediction*.¹

1.2 Scope

This document provides recommendations for projecting flux maintenance of LED light sources using data obtained when testing them per *ANSI/IES LM-80-15, Approved Method for Measuring Luminous Flux and Color Maintenance of LED Packages, Arrays and Modules*.

This method shall not be used to project lumen, photon or radiant flux maintenance below 70%.

2.0 Normative References

ANSI/IES LM-80-15, Approved Method for Measuring Luminous Flux and Color Maintenance of LED Packages, Arrays and Modules.

3.0 Definitions

In addition to the terms define in this section, illuminating engineering terms are defined in ANSI/IES RP-16-17.²

3.1 DUT

The *device under testing* is the LED light source as defined in **Section 3.2**.